

Approval Sheet

| | |
|-----------------------|--------------------------------------|
| Customer | |
| Product Number | M3DT-4GSS2LPC-E |
| Module speed | PC3-12800 |
| Pin | 204pin |
| CI-tRCD-tRP | 11-11-11 |
| Operating Temp | 0°C~85°C |
| Date | 15th November 2018 |

**The Total Solution For
Industrial Flash Storage**

Rev 1.2

1. Features

Key Parameter

| Industry Nomenclature | Speed Grade | Data Rate MT/s | | | CL | tRCD | tRP |
|--------------------------|----------------|----------------|------|-------|----|------|-----|
| | | CL=7 | CL=9 | CL=11 | | | |
| PC3-12800 | P | 1066 | 1333 | 1600 | 11 | 11 | 11 |

- JEDEC Standard 204-pin Small Outline Dual In-Line Memory Module
- Intend for PC3-12800 applications
- Inputs and Outputs are SSTL-15 compatible
- VDD=VDDQ= 1.35 Volt (-0.067/+0.1V) or 1.5 Volt ($\pm 0.075V$)
- Bi-directional Differential Data Strobe
- DLL aligns DQ and DQS transition with CK transition
- SDRAMs have 8 internal banks for concurrent operation
- Normal and Dynamic On-Die Termination support.
- SDRAMs are 78-ball BGA Package
- Gold Plating Thickness 30 μ m
- Temperature Sensor with SPD EEPROM
- 8 bit pre-fetch
- Two different termination values (Rtt_Nom & Rtt_WR)
- Auto & self refresh 7.8 μ s ($T_c \leq +85^{\circ}C$)
- 16/10/1 Addressing (row/column/rank)-4GB
- SDRAM operating temperature range
 - $0^{\circ}C \leq T_c \leq +85^{\circ}C$
- Programmable Device Operation:
 - Burst Type: Sequential or Interleave
 - Device CAS# Latency: 6,7,8,9,10,11
 - Burst Length: switch on-the-fly: BL=8 or BC 4
- RoHS Compliant (*Section 13*)

2. Environmental Requirements

DDR3L SODIMMs are intended for use in standard office environments that have limited capacity for heating and air conditioning.

| Symbol | Parameter | Rating | Units | Notes |
|--------|---|-------------|----------|-------|
| TOPR | Operating Temperature (ambient) | 0 to +65 | °C | 3 |
| HOPR | Operating Humidity (relative) | 10 to 90 | % | 1 |
| TSTG | Storage Temperature | -50 to +100 | °C | 1 |
| HSTG | Storage Humidity (without condensation) | 5 to 95 | % | 1 |
| PBAR | Barometric Pressure (operating & storage) | 105 to 69 | K Pascal | 1,2 |

1. Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only, and device functional operation at or above the conditions indicated is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
 2. Up to 9850 ft.
 3. The designer must meet the case temperature specifications for individual module components. Following JEDEC specifications.

3. SDRAM Parameters by device density

| RTT_Nom Setting | Parameter | | 4Gb | Units |
|-----------------|-------------------------------------|---------------------------------|-----|-------|
| tRFC | REF command ACT or REF command time | | 260 | ns |
| tREFI | Average periodic refresh interval | 0°C ≤ T _{CASE} ≤ 85°C | 7.8 | µs |
| | | 85°C < T _{CASE} ≤ 95°C | 3.9 | µs |

4. Ordering Information

| DDR3L ECC SODIMM | | | | | | |
|------------------|---------|-----------|-------------------|----------------|----------------|-----|
| Part Number | Density | Speed | DIMM Organization | Number of DRAM | Number of rank | ECC |
| M3DT-4GSS2LPC-E | 4GB | PC3-12800 | 512Mx72 | 9 | 1 | Y |

5. Pin Configurations (Front side/Back side)

X72 SODIMM

| Front | | | | | | Back | | | | | |
|-------|--------|-----|----------|-----|--------|------|--------|-----|-------------------|-----|--------|
| Pin | Name | Pin | Name | Pin | Name | Pin | Name | Pin | Name | Pin | Name |
| 1 | VREFDQ | 69 | CB0 | 137 | VSS | 2 | VSS | 70 | VSS | 138 | VSS |
| 3 | VSS | 71 | CB1 | 139 | /DQS4 | 4 | DQ4 | 72 | CB4 | 140 | DM4 |
| 5 | DQ0 | 73 | VSS | 141 | DQS4 | 6 | DQ5 | 74 | CB5 | 142 | DQ38 |
| 7 | DQ1 | 75 | /DQS8 | 143 | VSS | 8 | VSS | 76 | DM8 | 144 | DQ39 |
| 9 | VSS | 77 | DQS8 | 145 | DQ34 | 10 | /DQS0 | 78 | VSS | 146 | VSS |
| 11 | DM0 | 79 | VSS | 147 | DQ35 | 12 | DQS0 | 80 | CB6 | 148 | DQ44 |
| 13 | DQ2 | 81 | CB2 | 149 | VSS | 14 | VSS | 82 | CB7 | 150 | DQ45 |
| 15 | DQ3 | 83 | CB3 | 151 | DQ40 | 16 | DQ6 | 84 | VREFCA | 152 | VSS |
| 17 | VSS | 85 | VDD | 153 | DQ41 | 18 | DQ7 | 86 | VDD | 154 | /DQS5 |
| 19 | DQ8 | 87 | CKE0 | 155 | VSS | 20 | VSS | 88 | A15 | 156 | DQ55 |
| 21 | DQ9 | 89 | CKE1 | 157 | DM5 | 22 | DQ12 | 90 | A14 | 158 | VSS |
| 23 | VSS | 91 | BA2 | 159 | DQ42 | 24 | DQ13 | 92 | A9 | 160 | DQ46 |
| 25 | /DQS1 | 93 | VDD | 161 | DQ43 | 26 | VSS | 94 | VDD | 162 | DQ47 |
| 27 | DQS1 | 95 | A12, /BC | 163 | VSS | 28 | DM1 | 96 | A11 | 164 | VSS |
| 29 | VSS | 97 | A8 | 165 | DQ48 | 30 | /RESET | 98 | A7 | 166 | DQ52 |
| 31 | DQ10 | 99 | A5 | 167 | DQ49 | 32 | VSS | 100 | A6 | 168 | DQ53 |
| 33 | DQ11 | 101 | VDD | 169 | VSS | 34 | DQ14 | 102 | VDD | 170 | VSS |
| 35 | VSS | 103 | A3 | 171 | /DQS6 | 36 | DQ15 | 104 | A4 | 172 | DM6 |
| 37 | DQ16 | 105 | A1 | 173 | DQS6 | 38 | VSS | 106 | A2 | 174 | DQ54 |
| 39 | DQ17 | 107 | A0 | 175 | VSS | 40 | DQ20 | 108 | BA1 | 176 | DQ55 |
| 41 | VSS | 109 | VDD | 177 | DQ50 | 42 | DQ21 | 110 | VDD | 178 | VSS |
| 43 | /DQS2 | 111 | CK0 | 179 | DQ51 | 44 | DM2 | 112 | Par_in, NC, CK1 | 180 | DQ60 |
| 45 | DQS2 | 113 | /CK0 | 181 | VSS | 46 | VSS | 114 | Err_out, NC, /CK1 | 182 | DQ61 |
| 47 | VSS | 115 | VDD | 183 | DQ56 | 48 | DQ22 | 116 | VDD | 184 | VSS |
| 49 | DQ18 | 117 | A10, AP | 185 | DQ57 | 50 | DQ23 | 118 | /S3 | 186 | /DQS7 |
| 51 | DQ19 | 119 | BA0 | 187 | VSS | 52 | VSS | 120 | /S2 | 188 | DQ57 |
| 53 | VSS | 121 | /WE | 189 | DM7 | 54 | DQ28 | 122 | /RAS | 190 | VSS |
| 55 | DQ24 | 123 | VDD | 191 | DQ58 | 56 | DQ29 | 124 | VDD | 192 | DQ62 |
| 57 | DQ25 | 125 | /CAS | 193 | DQ59 | 58 | VSS | 126 | ODT0 | 194 | DQ63 |
| 59 | DM3 | 127 | /S0 | 195 | VSS | 60 | /DQS3 | 128 | ODT1 | 196 | VSS |
| 61 | VSS | 129 | /S1 | 197 | SA0 | 62 | DQS3 | 130 | A13 | 198 | /EVENT |
| 63 | DQ26 | 131 | VDD | 199 | VDDSPD | 64 | VSS | 132 | VDD | 200 | SDA |
| 65 | DQ27 | 133 | DQ32 | 201 | SA1 | 66 | DQ30 | 134 | DQ36 | 202 | SCL |
| 67 | VSS | 135 | DQ33 | 203 | VTT | 68 | DQ31 | 136 | DQ37 | 204 | VTT |

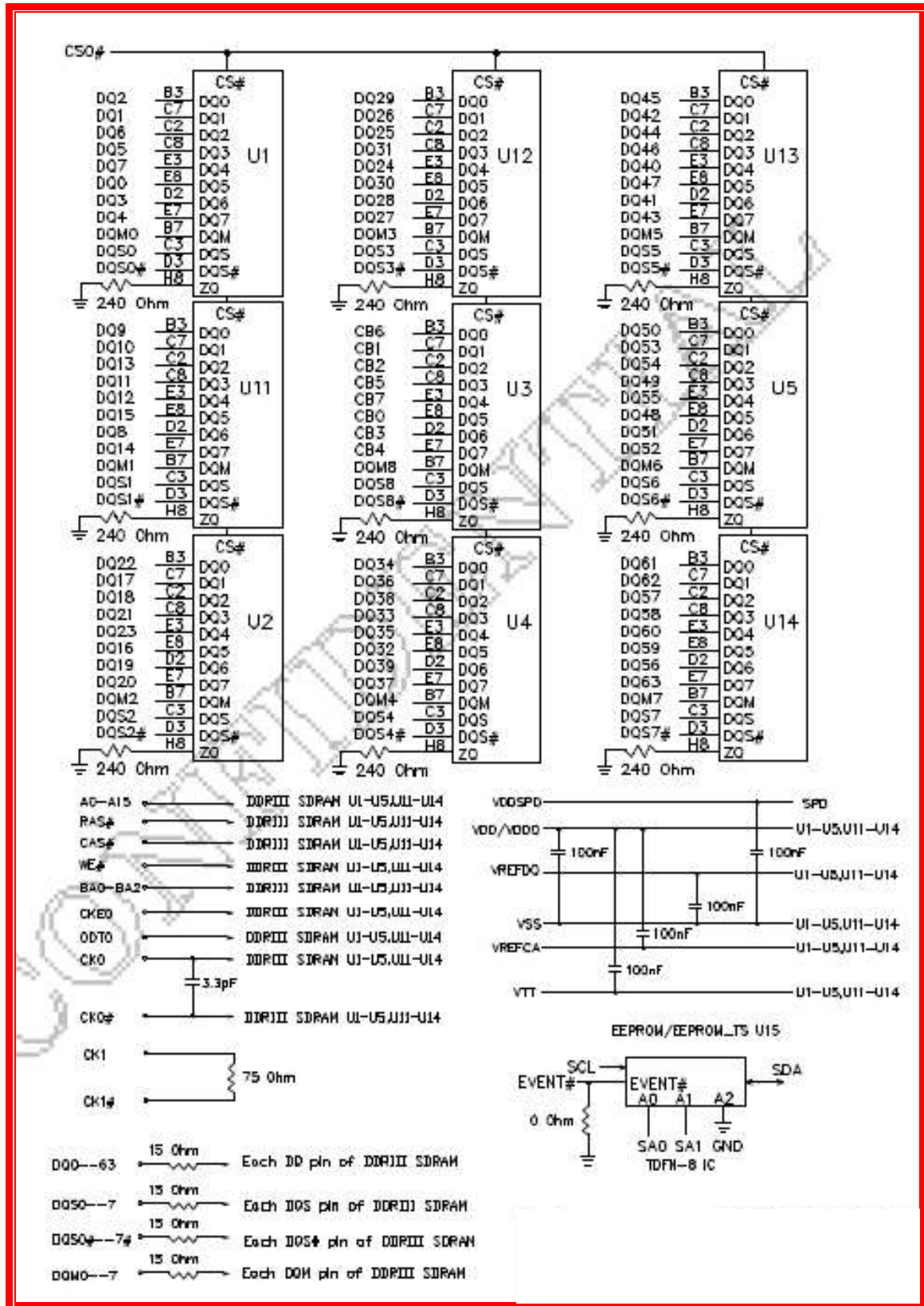
* This address might be connected to NC balls of the DRAMs (depending on density); either way they will be connected to the termination resistor.

6. Architecture

Pin Definition

| Pin Name | Description | Pin Name | Description |
|-------------------------|--|--------------------|---|
| CK0 | Clock Inputs, positive line | Par_In | Parity bit for the Address and Control bus |
| /CK0 | Clock inputs, negative line | /Err_Out | Parity error found on the Address and Control bus |
| CK1 | Clock Inputs, positive line | ODT[1:0] | On-die termination control |
| /CK1 | Clock inputs, negative line | DQ[63:0] | Data Input/Output |
| CKE[1:0] | Clock Enables | CB[7:0] | Data check bits Input/Output |
| /RAS | Row Address Strobe | DQS[8:0] | Data strobes |
| /CAS | Column Address Strobe | /DQS[8:0] | Data strobes, negative line |
| /WE | Write Enable | DM[8:0] | Data Masks / Data strobes, Termination data strobes |
| /S[3:0] | Chip Selects | /EVENT | Reserved for optional hardware temperature sensing |
| A[9:0],A11, A[15:13] | Address Inputs | /RESET | Register and SDRAM control pin |
| A10,AP | Address Input/Autoprecharge | V _{DD} | Power Supply |
| A12,/BC | Address Input/Burst chop | V _{SS} | Ground |
| BA[2:0] | SDRAM Bank Address | V _{REFDQ} | Reference Voltage for DQ |
| SCL | Serial Presence Detect (SPD) Clock Input | V _{REFCA} | Reference Voltage for CA |
| SDA | SPD Data Input/Output | V _{TT} | Termination voltage |
| SA[1:0] | SPD Address Inputs | V _{DDSPD} | SPD Power |

7. Function Block Diagram:
 - (4GB, 1 Rank, 512Mx8 DDR3L SDRAMs)



8. SDRAM Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units | Note | |
|------------------------------------|--|------------------------|----------|------|-----|
| T _{OPER} | Operation Temperature | Normal Operating Temp. | 0 to 85 | °C | 1,2 |
| | | Extended Temp. | 85 to 95 | °C | 1,3 |
| T _{STG} | Storage Temperature | -55 to 100 | °C | | 4,5 |
| V _{IN} , V _{OUT} | Voltage on any pins relative to V _{SS} | -0.4 to +1.8 | V | | 4 |
| V _{DD} | Voltage on VDD supply relative to V _{SS} | -0.4 to +1.8 | V | | 4,6 |
| V _{DDQ} | Voltage on VDDQ supply relative to V _{SS} | -0.4 to +1.8 | V | | 4,6 |

Note:

- Operating Temperature TOPER is the case surface temperature on the center / top side of the DRAM. For measurement conditions, please refer to the JEDEC document JESD51-2.
- The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between 0 to 85 °C under all operating conditions.
- Some applications require operation of the DRAM in the Extended Temperature Range between 85 °C and 95 °C case temperature. Full specifications are supported in this range, but the following additional conditions apply:
 - Refresh commands must be doubled in frequency, therefore reducing the Refresh interval tREFI to 3.9 μs. It is also possible to specify a component with 1X refresh (tREFI to 7.8μs) in the Extended Temperature Range. Please refer to supplier data sheet and/or the DIMM SPD for option availability.
 - If Self-Refresh operation is required in the Extended Temperature Range, then it is mandatory to either use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 A6 =0b and MR2 A7 = 1b) or enable the optional Auto Self-Refresh mode (MR2 A6 = 1b and MR2 A7 =0b). Please refer to the supplier data sheet and/or the DIMM SPD for Auto Self-Refresh option availability, Extended Temperature Range support and tREFI requirements in the Extended Temperature Range.
- Stresses greater than those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- Storage Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51-2 standard.
- VDD and VDDQ must be within 300 mV of each other at all times;and VREF must be not greater than 0.6 x VDDQ, When VDD and VDDQ are less than 500 mV; VREF may be equal to or less than 300 mV

9. DRAM AC & DC Operating

| Symbol | Parameter | Min | Typ. | Max | Units | Notes |
|--|--|------------------------|------------------------|------------------------|-------|-------|
| Recommended DC Operating Conditions | | | | | | |
| Recommended DC Operating Conditions - DDR3L (1.35V) operation | | | | | | |
| V _{DD} | Supply Voltage | 1.283 | 1.35 | 1.45 | V | 1,2 |
| V _{DDSPD} | Supply Voltage | 3 | 3.3 | 3.6 | V | |
| V _{DDQ} | Supply Voltage | 1.283 | 1.35 | 1.45 | V | 1,2 |
| Recommended DC Operating Conditions - DDR3 (1.5V) operation | | | | | | |
| V _{DD} | Supply Voltage | 1.425 | 1.5 | 1.575 | V | 1,2 |
| V _{DDSPD} | Supply Voltage | 3 | 3.3 | 3.6 | V | |
| V _{DDQ} | Supply Voltage | 1.425 | 1.5 | 1.575 | V | 1,2 |
| Single Ended AC/DC Input Levels | | | | | | |
| V _{IH} (DC) DDR3L | DC Input High (Logic1) Voltage | V _{REF} + 90 | - | V _{DD} | V | 3 |
| V _{IH} (DC) DDR3 | DC Input High (Logic1) Voltage | V _{REF} + 100 | | V _{DD} | V | 3 |
| V _{IL} (DC) DDR3L | DC Input Low (Logic 0) Voltage | V _{SS} | - | V _{REF} - 90 | V | 3 |
| V _{IL} (DC) DDR3 | DC Input Low (Logic 0) Voltage | V _{SS} | | V _{REF} - 100 | V | 3 |
| V _{IH} (AC) DDR3L | AC Input High (Logic1) Voltage | V _{REF} + 135 | - | - | V | 3 |
| V _{IH} (AC) DDR3 | AC Input High (Logic1) Voltage | V _{REF} + 150 | | | V | 3 |
| V _{IL} (AC) DDR3L | AC Input Low (Logic 0) Voltage | - | - | V _{REF} - 135 | V | 3 |
| V _{IL} (AC) DDR3 | AC Input Low (Logic 0) Voltage | | | V _{REF} - 150 | V | 3 |
| V _{REFDQ} (DC) | Reference Voltage for DQ, DM inputs | 0.49V _{DDQ} | 0.5V _{DDQ} | 0.51V _{DDQ} | V | 4,5 |
| V _{REFCA} (DC) | Reference Voltage for ADD,CMD inputs | 0.49V _{DDQ} | 0.5V _{DDQ} | 0.51V _{DDQ} | V | 4,5 |
| Single Ended AC/DC Output Levels | | | | | | |
| V _{OH} (DC) | DC output high measurement level (for IV curve linearity) | - | 0.8 x V _{DDQ} | - | V | |
| V _{OM} (DC) | DC output mid measurement level (for IV curve linearity) | - | 0.5 x V _{DDQ} | - | V | |
| V _{OL} (DC) | DC output low measurement level (for IV curve linearity) | - | 0.2 x V _{DDQ} | - | V | |

| | | | | | | |
|-----------------|---|---|-------------------------------|---|---|---|
| VOH (AC) | AC output high measurement level (for output SR) | - | $V_{TT} + 0.1 \times V_{DDQ}$ | - | V | 6 |
| VOL (AC) | AC output low measurement level (for output SR) | | $V_{TT} - 0.1 \times V_{DDQ}$ | - | V | 6 |

| Symbol | Parameter | Min | Typ. | Max | Units | Notes |
|---|---|-------------------------------|------------------------|-------------------------------|-------|-------|
| Differential AC/DC Input Levels | | | | | | |
| VIHdiff DDR3L | Differential Input high | +0.18 | - | Note 9 | V | 7 |
| VIHdiff DDR3 | Differential Input high | +0.2 | | Note 9 | V | 7 |
| VILdiff DDR3L | Differential Input logic Low | Note 9 | - | -0.18 | V | 7 |
| VILdiff DDR3 | Differential Input logic Low | Note 9 | - | -0.2 | V | 7 |
| VIHdiff(ac) DDR3L | Differential Input high ac | $2^* (V_{IH} (AC) - V_{REF})$ | - | Note 9 | V | 8 |
| VIHdiff(ac) DDR3 | Differential Input high ac | $2^* (V_{IH} (AC) - V_{REF})$ | - | Note 9 | V | 8 |
| VILdiff(ac) DDR3L | Differential Input logic Low ac | Note 9 | - | $2^* (V_{REF} - V_{IL} (AC))$ | V | 8 |
| VILdiff(ac) DDR3 | Differential Input logic Low ac | Note 9 | - | $2^* (V_{REF} - V_{IL} (AC))$ | V | 8 |
| Differential AC and DC Output Levels | | | | | | |
| VOHdiff(AC) | AC differential output high measurement level (for output SR) | - | $+ 0.2 \times V_{DDQ}$ | - | V | 10 |
| VOLdiff(AC) | AC differential output low measurement level (for output SR) | - | $- 0.2 \times V_{DDQ}$ | - | V | 10 |

Note:

1. Under all conditions VDDQ must be less than or equal to VDD.
2. VDDQ tracks with VDD. AC parameters are measured with VDD and VDDQ tied together.
3. For DQ and DM, Vref = VrefDQ. For input only pins except RESET#, Vref = VrefCA.
4. Recommended DC Operating Conditions - DDR3 (1.5V) operation : The ac peak noise on VRef may not allow VRef to deviate from VRef(DC) by more than +/-1% VDD (for reference: approx. +/- 15 mV); Recommended DC Operating Conditions - DDR3L (1.35V) operation: The ac peak noise on VRef may not allow VRef to deviate from VRef(DC) by more than +/-1% VDD (for reference: approx. +/- 13.5 mV)
5. For reference: approx. VDD/2.
6. The swing of $\pm 0.1 \times VDDQ$ is based on approximately 50% of the static single-ended output high or low swing with a driver impedance of 40Ω and an effective test load of 25Ω to $V_{TT} = VDDQ/2$
7. Used to define a differential signal slew-rate.
8. For CK - CK# use VIH/VIL(ac) of ADD/CMD and VREFCA; for DQS - DQS#, DQSL, DQSL#, DQSU, DQSU# use VIH/VIL(ac) of DQs and VREFDQ; if a reduced ac-high or ac-low level is used for a signal group, then the reduced level applies also here.
9. These values are not defined, however the single-ended signals CK, CK#, DQS, DQS#, DQSL, DQSL#, DQSU, DQSU# need to be within the respective limits (VIH(dc) max, VIL(dc)min) for single-ended signals as well as the limitations for overshoot and undershoot.
10. The swing of $\pm 0.2 \times VDDQ$ is based on approximately 50% of the static single-ended output high or low swing with a driver impedance of 40Ω and an effective test load of 25Ω to $V_{TT} = VDDQ/2$ at each of the differential outputs.

10. Operating, Standby, and Refresh Currents

- 4GB ECC SODIMM (1 Rank, 512Mx8 DDR3L SDRAMs)

| Symbol | Parameter/Condition | | PC3-12800 | Unit |
|--------|--|-----------|-----------|------|
| I DD0 | One bank; Active - Precharge | | 234 | mA |
| I DD1 | One bank; Active - Read - Precharge | | 324 | mA |
| I DD2N | Precharge Standby Current | | 99 | mA |
| IDD2NT | Precharge Standby ODT Current | | 117 | mA |
| I DD2P | Precharge Power Down Current | Fast Mode | 72 | mA |
| | Precharge Power Down Current | Slow Mode | 72 | mA |
| I DD2Q | Precharge Quiet Standby Current | | 90 | mA |
| I DD3N | Active Standby Current | | 189 | mA |
| I DD3P | Active Power-Down Current | | 90 | mA |
| I DD4R | Operating Current Burst Read | | 576 | mA |
| I DD4W | Operating Current Burst Write | | 567 | mA |
| I DD5B | Burst Refresh Current | | 1710 | mA |
| I DD6 | Self-Refresh Current: Normal Temperature Range | | 108 | mA |
| I DD7 | Operating Bank Interleave Read Current | | 1089 | mA |
| I DD8 | RESET Low Current | | 135 | mA |

11. Timing Parameters

| Symbol | Parameter | PC3-12800 | | Unit |
|---------------------|---|---------------------------------------|---|-----------|
| | | Min. | Max. | |
| Clock Timing | | | | |
| tCK (DLL-Off) | Minimum Clock Cycle Time | 8 | - | ns |
| tCK (avg) | Average Clock Period | 1.25 | <1.5 | ns |
| tCH (avg) | Average high pulse width | 0.47 | 0.53 | tCK (avg) |
| tCL (avg) | Average low pulse width | 0.47 | 0.53 | tCK (avg) |
| tCK (abs) | Absolute Clock Period | tCK(avg) min + tJIT(per) min | tCK(avg) max + tJIT(per) max - | Ps |
| tCH (abs) | Absolute high pulse width | 0.43 | - | tCK (avg) |
| tCL (abs) | Absolute low pulse width | 0.43 | - | tCK (avg) |
| JIT (per) | Clock Period Jitter | -70 | 70 | Ps |
| TJIT (per, lck) | Clock Period Jitter during DLL locking period. | -60 | 60 | Ps |
| JIT (CC) | Cycle to Cycle Period Jitter | 140 | | Ps |
| TJIT (CC, lck) | Cycle to Cycle Period Jitter during DLL locking period. | 120 | | Ps |
| TERR (2per) | Cumulative error across 2 cycle | -103 | 103 | Ps |
| TERR (3per) | Cumulative error across 3 cycle | -122 | 122 | Ps |
| TERR (4per) | Cumulative error across 4 cycle | -136 | 136 | Ps |
| TERR (5per) | Cumulative error across 5 cycle | -147 | 147 | Ps |
| TERR (6per) | Cumulative error across 6 cycle | -155 | 155 | Ps |
| TERR (7per) | Cumulative error across 7 cycle | -163 | 163 | Ps |
| TERR (8per) | Cumulative error across 3 cycle | -169 | 169 | Ps |
| TERR (9per) | Cumulative error across 4 cycle | -175 | 175 | Ps |
| TERR (10per) | Cumulative error across 5 cycle | -180 | 180 | Ps |
| TERR (11per) | Cumulative error across 6 cycle | -184 | 184 | Ps |
| TERR (12per) | Cumulative error across 7 cycle | -188 | 188 | Ps |

| | | | | |
|---------------------------|---|--|-------------|-------------|
| TERR (nper) | Cumulative error across 13~50 cycle | $tERR(nper)_{min} = (1 + 0.68 \ln(n)) * tJIT(per)_{min}$ $tERR(nper)_{max} = (1 + 0.68 \ln(n)) * tJIT(per)_{max}$ | | Ps |
| Data Timing | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| tDQSQ | DQS, DQS# to DQ skew, per group, per access | - | 100 | Ps |
| tQH | DQ output hold time from DQS, DQS# | 0.38 | - | tCK(avg) |
| tLZ (DQ) | DQ low-impedance time from CK, CK# | -450 | 225 | Ps |
| tHZ(DQ) | DQ high impedance time from CK, CK# | - | 225 | Ps |
| 1.35V | | | | |
| tDS(base) AC160 | Data setup time to DQS, DQS# referenced to Vih(ac) / Vil(ac) levels | - | - | Ps |
| tDS(base) AC135 | | 25 | - | Ps |
| tDS(base) AC125 | | - | - | Ps |
| tDH(base) DC90 | Data hold time from DQS, DQS# referenced to VIH(DC)VIL(DC) levels | 55 | - | Ps |
| 1.5V | | | | |
| tDS(base) AC175 | Data setup time to DQS, DQS# referenced to Vih(ac) / Vil(ac) levels | - | - | Ps |
| tDS(base) AC150 | | 10 | - | Ps |
| tDS(base) AC135 | | - | - | Ps |
| tDH(base) DC100 | Data hold time from DQS, DQS# referenced to VIH(DC)VIL(DC) levels | 45 | - | Ps |
| Data Strobe Timing | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| tRPRE | DQS,DQS# differential READ Preamble | 0.9 | | tCK(avg) |
| tRPST | DQS, DQS# differential READ Postamble | 0.3 | | tCK(avg) |

| | | | | |
|-----------------------------------|---|----------------------|-------------|-------------|
| tQSH | DQS, DQS# differential output high time | 0.4 | | tCK(avg) |
| tQSL | DQS, DQS# differential output low time | 0.4 | | tCK(avg) |
| tWPRE | DQS, DQS# differential WRITE Preamble | 0.9 | | tCK(avg) |
| tWPST | DQS, DQS# differential WRITE Postamble | 0.3 | | tCK(avg) |
| tDQCK | DQS, DQS# rising edge output access time from rising CK, CK# | -225 | 225 | Ps |
| tLZ(DQS) | DQS and DQS# low-impedance time (Referenced from RL - 1) | -450 | 225 | Ps |
| tHZ(DQS) | DQS and DQS# high-impedance time (Referenced from RL + BL/2) | - | 225 | Ps |
| tDQSL | DQS, DQS# differential input low pulse width | 0.45 | 0.55 | tCK(avg) |
| tDQSH | DQS, DQS# differential input high pulse width | 0.45 | 0.55 | tCK(avg) |
| tDQSS | DQS, DQS# rising edge to CK, CK# rising edge | -0.27 | 0.27 | tCK(avg) |
| tDSS | DQS, DQS# falling edge setup time to CK, CK# rising edge | 0.18 | - | tCK(avg) |
| tDSH | DQS, DQS# falling edge hold time from CK, CK# rising edge | 0.18 | - | tCK(avg) |
| Command and Address Timing | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| tDLLK | DLL locking time | 512 | - | nCK |
| tRTP | Internal READ Command to PRECHARGE Command delay | max(4nC K, 7.5ns) | - | |
| tWTR | Delay from start of internal write transaction to Internal read command | max(4nC K, 7.5ns) | - | |
| tWR | WRITE recovery time | 15 | - | ns |
| tMRD | Mode Register Set command cycle time | 4 | - | nCK |
| tMOD | Mode Register Set command update delay | max(12n CK, 15ns) | - | |
| tRCD | Refer to Section 1 Feature | | | |
| tRP | Refer to Section 1 Feature | | | |
| tRC | Refer to Section 1 Feature | | | |

| | | | | |
|---------------------------|--|--|----------|-----|
| tCCD | | 4 | - | nCK |
| tDAL (min) | Auto precharge write recovery + precharge time | WR + roundup($t_{RP} / t_{CK}(avg)$) | | nCK |
| tMPRR | Multi-Purpose Register Recovery Time | 1 | - | nCK |
| tRAS | ACTIVE to PRECHARGE command period | 35 | 9 *tREFI | ns |
| tRRD | ACTIVE to ACTIVE command period for 1KB page size | max(4nC K, 6ns) | - | |
| tRRD | ACTIVE to ACTIVE command period for 2KB page size | max(4nC K, 7.5ns) | - | |
| tFAW | Four activate window for 1KB page size | 30 | - | ns |
| tFAW | Four activate window for 2KB page size | 40 | - | ns |
| 1.35V | | | | |
| tIS(base) AC160 | Command and Address setup time to CK, CK# referenced to VIH(AC) / VIL(AC) levels | 60 | - | Ps |
| tIS(base) AC135 | | 185 | - | Ps |
| tIS(base) AC125 | | - | - | Ps |
| tIH(base) DC90 | Command and Address hold time from CK, CK# referenced to VIH(DC) / VIL(DC) levels | 130 | - | Ps |
| 1.5V | | | | |
| tIS(base) AC175 | Command and Address setup time to CK, CK# referenced to VIH(AC) / VIL(AC) levels | 45 | - | Ps |
| tIS(base) AC150 | | 170 | - | Ps |
| tIS(base) AC135 | | - | - | Ps |
| tIS(base) AC125 | | - | - | Ps |
| tIH(base) DC100 | Command and Address hold time from CK, CK# referenced to VIH(DC) / VIL(DC) levels | 120 | - | Ps |
| Calibration Timing | | | | |

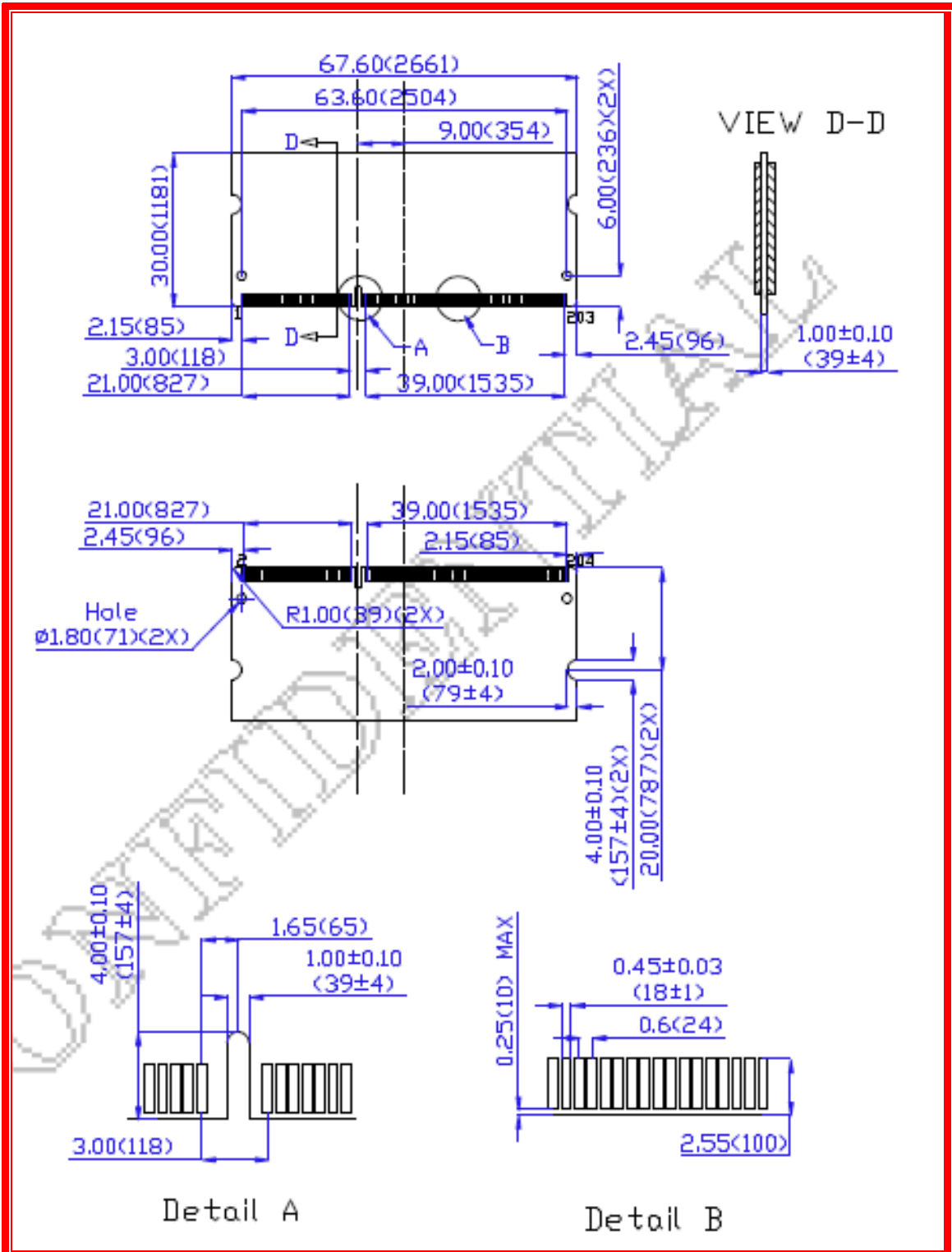
| Symbol | Parameter | Min. | Max. | Unit |
|-----------------------------|--|-------------------------|------|------|
| tZQinit | Power-up and RESET calibration time | 512 | - | nCK |
| tZQoper | Normal operation Full calibration time | 256 | - | nCK |
| tZQCS | Normal operation Short calibration time | 64 | - | nCK |
| Reset Timing | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| tXPR | Exit Reset from CKE HIGH to a valid command | max(5nCK, tRFC + 10ns) | - | |
| Self Refresh Timings | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| tXS | Exit Self Refresh to commands not requiring a locked DLL | Max(5nCK), tRFC + 10ns) | | |
| tXSDLL | Exit Self Refresh to commands requiring a locked DLL. | tDLL(min) | - | nCK |
| tCKESR | Minimum CKE low width for Self Refresh entry to exit timing. | tCKE(min) + 1tCK | - | |
| tCKSRE | Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE) | Max(5nCK, 10ns) | - | |
| tCKSRX | Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit | Max(5nCK, 10ns) | - | |
| Power Down Timings | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| tXP | Exit Power Down with DLL on to any valid command; Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL | max(3nCK, 6ns) | - | |
| tXPDLL | Exit Precharge Power Down with DLL frozen to commands requiring a locked DLL | max(10nCK, 24ns) | - | |

| | | | | |
|--------------------|--|-----------------------------|-------------|-------------|
| tCKE | CKE minimum pulse width | $\max(3nCK, 5ns)$ | - | |
| tCPDED | Command pass disable delay | 1 | - | nCK |
| tPD | Power Down Entry to Exit Timing | tCKE(min) | 9*tREFI | |
| tACTPDEN | Timing of ACT command to Power Down entry | 1 | - | nCK |
| tPRPDEN | Timing of PRE or PREA command to Power Down entry | 1 | - | nCK |
| tRDPDEN | Timing of RD/RDA command to Power Down entry | RL+4+1 | - | nCK |
| tWRPDEN | Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BC4OTF) | $WL + 4 + (tWR / tCK(avg))$ | - | nCK |
| tWRAPDEN | Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BC4OTF) | $WL + 4 + WR + 1$ | - | nCK |
| tWRPDEN | Timing of WR command to Power Down entry (BC4MRS) | $WL + 2 + (tWR / tCK(avg))$ | - | nCK |
| tWRAPDEN | Timing of WRA command to Power Down entry (BC4MRS) | $WL + 2 + WR + 1$ | - | nCK |
| tREFPDEN | Timing of REF command to Power Down entry | 1 | - | nCK |
| tMRSPDEN | Timing of MRS command to Power Down entry | tMOD(min) | - | nCK |
| ODT Timings | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| ODTH4 | ODT high time without write command or with write command and BC4 | 4 | - | nCK |
| ODTH8 | ODT high time with Write command and BL8 | 6 | - | nCK |
| tAONPD | Asynchronous RTT turn-on delay (Power-Down with DLL frozen) | 2 | 8.5 | ns |
| tAOFPD | Asynchronous RTT turn-off delay (Power-Down with DLL frozen) | 2 | 8.5 | ns |

| | | | | |
|------------------------------|---|-------------|-------------|-------------|
| tAON | RTT-turn-on | -225 | 225 | ps |
| tAOF | RTT_Nom and RTT_WR turn-off time from ODTLoff reference | 0.3 | 0.7 | tCK(avg) |
| tADC | RTT dynamic change skew | 0.3 | 0.7 | tCK(avg) |
| Write Leveling Timing | | | | |
| Symbol | Parameter | Min. | Max. | Unit |
| tWLMRD | First DQS/DQS# rising edge after write leveling mode is programmed | 40 | - | nCK |
| tWLDQSEN | DQS/DQS# delay after write leveling mode is programmed | 25 | - | nCK |
| tWLS | Write leveling setup time from rising CK, CK# crossing to rising DQS, DQS# crossing | 165 | - | ps |
| tWLH | Write leveling hold time from rising DQS, DQS# crossing to rising CK, CK# crossing | 165 | - | ps |
| tWLO | Write leveling output delay | 0 | 7.5 | ns |
| tWLOE | Write leveling output error | 0 | 2 | ns |

12. PACKAGE DIMENSION

- (4GB, 1 Rank, 512Mx8 DDR3L base SODIMM)



Note: All dimensions are in millimeters (mils) and should be kept within a tolerance of ±0.15 (6), unless otherwise specified

13. RoHS Declaration

| | | |
|--|--|----------|
| innodisk | 宜鼎國際股份有限公司 Innodisk Corporation | Page 1/1 |
| Tel: (02) 7703-3000 Fax: (02) 7703-3555 Internet: http://www.innodisk.com/ | | |
| RoHS 自我宣告書 (RoHS Declaration of Conformity) | | |
| Manufacturer Product: All Innodisk EM Flash and Dram products | | |
| 一、 宜鼎國際股份有限公司 (以下稱本公司) 特此保證售予貴公司之所有產品, 皆符合歐盟 2011/65/EU 及 (EU) 2015/863 關於 RoHS 之規範要求。 | | |
| Innodisk Corporation declares that all products sold to the company, are complied with European Union RoHS Directive (2011/65/EU) and (EU) 2015/863 requirement. | | |
| 二、 本公司同意因本保證書或與本保證書相關事宜有所爭議時, 雙方宜友好協商, 達成協議。 | | |
| Innodisk Corporation agrees that both parties shall settle any dispute arising from or in connection with this Declaration of Conformity by friendly negotiations. | | |
| Name of hazardous substance | Limited of RoHS ppm (mg/kg) | |
| 鉛 (Pb) | < 1000 ppm | |
| 汞 (Hg) | < 1000 ppm | |
| 鎘 (Cd) | < 100 ppm | |
| 六價鉻 (Cr 6+) | < 1000 ppm | |
| 多溴聯苯 (PBBs) | < 1000 ppm | |
| 多溴二苯醚 (PBDEs) | < 1000 ppm | |
| 鄰苯二甲酸二(2-乙基己基)酯 (DEHP) | < 1000 ppm | |
| 鄰苯二甲酸丁酯苯甲酯 (BBP) | < 1000 ppm | |
| 鄰苯二甲酸二丁酯 (DBP) | < 1000 ppm | |
| 鄰苯二甲酸二異丁酯 (DIBP) | < 1000 ppm | |
| 立 保 證 書 人 (Guarantor) | | |
| Company name 公司名稱: <u>Innodisk Corporation 宜鼎國際股份有限公司</u> | | |
| Company Representative 公司代表人: <u>Randy Chien 簡川勝</u> | | |
| Company Representative Title 公司代表人職稱: <u>Chairman 董事長</u> | | |
| Date 日期: <u>2017 / 01 / 18</u> | | |
|  | | |

Revision Log

| Rev | Date | Modification |
|-----|---------------------------------|-------------------------------|
| 0.1 | 3 rd October 2016 | Preliminary Edition |
| 1.0 | 3 rd October 2016 | Official released. |
| 1.1 | 19 th September 2017 | Modify typo |
| 1.2 | 15 th November 2018 | Updated 11. Timing Parameters |